

October 1987 Revised March 2002

CD4028BC BCD-to-Decimal Decoder

General Description

The CD4028BC is a BCD-to-decimal or binary-to-octal decoder consisting of 4 inputs, decoding logic gates, and 10 output buffers. A BCD code applied to the 4 inputs, A, B, C, and D, results in a high level at the selected 1-of-10 decimal decoded outputs. Similarly, a 3-bit binary code applied to inputs A, B, and C is decoded in octal at outputs 0–7. A high level signal at the D input inhibits octal decoding and causes outputs 0–7 to go LOW.

All inputs are protected against static discharge damage by diode clamps to $\rm V_{DD}$ and $\rm V_{SS}.$

Features

■ Wide supply voltage range: 3.0V to 15V

■ High noise immunity: 0.45 V_{DD} (typ.)

■ Low power TTL compatibility: fan out of 2 driving 74L

or 1 driving 74LS

■ Low power

■ Glitch free outputs

■ "Positive logic" on inputs and outputs

Applications

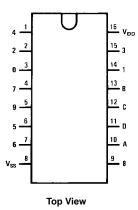
- · Code conversion
- · Address decoding
- · Indicator-tube decoder

Ordering Code:

Order Number	Package Number	Package Description
CD4028BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4028BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

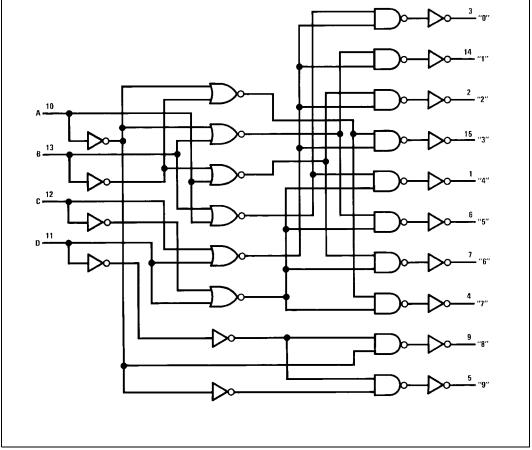
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Truth Table С D В Α BCD States 1 = HIGH Level 0 = LOW Level Extraordinary States

Logic Diagram



Absolute Maximum Ratings(Note 1)

(Note 2)

Supply Voltage (V_{DD}) -0.5 to +18VInput Voltage (V_{IN}) -0.5 to V_{DD} +0.5V

Storage Temperature Range (T_S) -65°C to +150°C

Power Dissipation (P_D)

Dual-In-Line 700 mW Small Outline 500 mW

Lead Temperature (T_L)

260°C (Soldering, 10 seconds)

Recommended Operating Conditions (Note 2)

Supply Voltage (V_{DD}) 3 to 15V 0 to V_{DD}V Input Voltage (V_{IN})

Operating Temperature Range (T_A)

 $-55^{\circ}C$ to $+125^{\circ}C$

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed, they are not meant to imply that the devices should be operated at these limits. The table of "Recommended Operating Conditions" and "Electrical Characteristics" provides $% \left(1\right) =\left(1\right) \left(1\right) \left($ conditions for actual device operation.

Note 2: $V_{SS} = 0V$ unless otherwise specified.

DC Electrical Characteristics (Note 2)

Symbol	Parameter	Conditions	–55°C		+25°C			+125°C		Units
			Min	Max	Min	Тур	Max	Min	Max	Jillis
I _{DD}	Quiescent Device Current	$V_{DD} = 5V$, $V_{IN} = V_{DD}$ or V_{SS}		5		0.01	5		150	
		$V_{DD} = 10V$, $V_{IN} = V_{DD}$ or V_{SS}		10		0.01	10		300	μΑ
		$V_{DD} = 15V$, $V_{IN} = V_{DD}$ or V_{SS}		20		0.02	20		600	
V _{OL}	LOW Level Output Voltage	$ I_O $ < 1 μ A, V_{IL} = 0V, V_{IH} = V_{DD}								
		$V_{DD} = 5V$		0.05		0	0.05		0.05	
		$V_{DD} = 10V$		0.05		0	0.05		0.05	V
		$V_{DD} = 15V$		0.05		0	0.05		0.05	
V _{OH}	HIGH Level Output Voltage	$ I_{O} < 1 \mu A, V_{IL} = 0V, V_{IH} = V_{DD}$								
		$V_{DD} = 5V$	4.95		4.95	5		4.95		
		$V_{DD} = 10V$	9.95		9.95	10		9.95		V
		$V_{DD} = 15V$	14.95		14.95	15		14.95		
V _{IL}	LOW Level Input Voltage	I _O < 1 μA								
		$V_{DD} = 5V$, $V_{O} = 0.5V$ or 4.5V		1.5		2.25	1.5		1.5	
		$V_{DD} = 10V$, $V_{O} = 1V$ or 9V		3.0		4.5	3.0		3.0	V
		$V_{DD} = 15V$, $V_{O} = 1.5V$ or $13.5V$		4.0		6.75	4.0		4.0	
V _{IH}	HIGH Level Input Voltage	I _O < 1 μA								
		$V_{DD} = 5V$, $V_{O} = 0.5V$ or 4.5V	3.5		3.5	2.75		3.5		
		$V_{DD} = 10V$, $V_{O} = 1V$ or $9V$	7.0		7.0	5.5		7.0		V
		$V_{DD} = 15V$, $V_{O} = 1.5V$ or $13.5V$	11.0		11.0	8.25		11.0		
I _{OL}	LOW Level Output Current	$V_{IH} = V_{DD}, V_{IL} = 0V$								
	(Note 3)	$V_{DD} = 5V, V_{O} = 0.4V$	0.64		0.51	1.0		0.36		
		$V_{DD} = 10V, V_{O} = 0.5V$	1.6		1.3	2.6		0.9		mA
		$V_{DD} = 15V, V_{O} = 1.5V$	4.2		3.4	6.8		2.4		
011	HIGH Level Output Current	$V_{IH} = V_{DD}, V_{IL} = 0V$								
	(Note 3)	$V_{DD} = 5V, V_{O} = 4.6V$	-0.25		-0.2	-0.4		-0.14		
		$V_{DD} = 10V, V_{O} = 9.5V$	-0.62		-0.5	-1.0		-0.35		mA
		$V_{DD} = 15V$, $V_{O} = 13.5V$	-1.8		-1.5	-3.0		-1.1		
I _{IN}	Input Current	$V_{DD} = 15V$, $V_{IN} = 0V$		-0.1			-0.1		-1.0	
		$V_{DD} = 15V$, $V_{IN} = 15V$		0.1			0.1		1.0	μΑ
	L	- !	·		·		·		·	

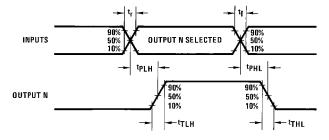
Note 3: $\rm I_{OL}$ and $\rm I_{OH}$ are tested one output at a time.

AC Electrical Characteristics (Note 4) $T_A=25^{\circ}C,\,C_L=50\;\text{pF},\,R_L=200k,\,\text{Input}\,\,t_r=t_f=20\;\text{ns},\,\text{unless otherwise specified}$

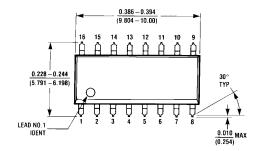
Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{PHL} or t _{PLH}	Propagation Delay Time	V _{CC} = 5V		240	480	
		$V_{CC} = 5V$ $V_{CC} = 10V$		100	200	ns
		$V_{CC} = 15V$		70	140	
t _{THL} or t _{TLH}	Transition Time	V _{CC} = 5V		175	350	
		$V_{CC} = 5V$ $V_{CC} = 10V$ $V_{CC} = 15V$		75	150	ns
		V _{CC} = 15V		60	110	
C _{IN}	Input Capacitance	Any Input		5	7.5	pF

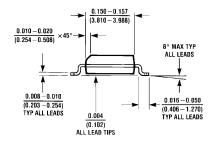
Note 4: AC Parameters are guaranteed by DC correlated testing.

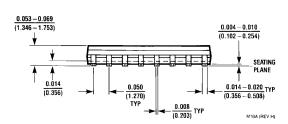
Switching Time Waveforms



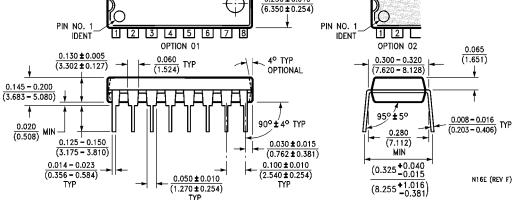
Physical Dimensions inches (millimeters) unless otherwise noted







16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com